

Notice of References Cited	Application/Control No. 10/727,887	Applicant(s)/Patent Under Reexamination RUDECK, PAUL	
	Examiner Toniae M. Thomas	Art Unit 2822	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0017680 A1	02-2002	Na et al.	257/315
	B	US-4,757,360	07-1988	Faraone, Lorenzo	257/317
	C	US-5,281,548	01-1994	Prall, Kirk D.	438/259
	D	US-5,480,820	01-1996	Roth et al.	438/257
	E	US-5,880,991	03-1999	Hsu et al.	365/182
	F	US-6,051,467	04-2000	Chan et al.	438/264
	G	US-6,323,514 B1	11-2001	Kao, David Y.	257/315
	H	US-6,329,240 B1	12-2001	Hsu et al.	438/253
	I	US-6,329,277 B1	12-2001	Liu et al.	438/612
	J	US-6,376,310 B1	04-2002	Kim, Yong Hee	438/263
	K	US-6,537,880 B1	03-2003	Tseng, Horng-Huei	438/260
	L	US-6,764,905 B2	07-2004	Jeng et al.	438/267
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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